

Figure 1. Internal schematic diagram

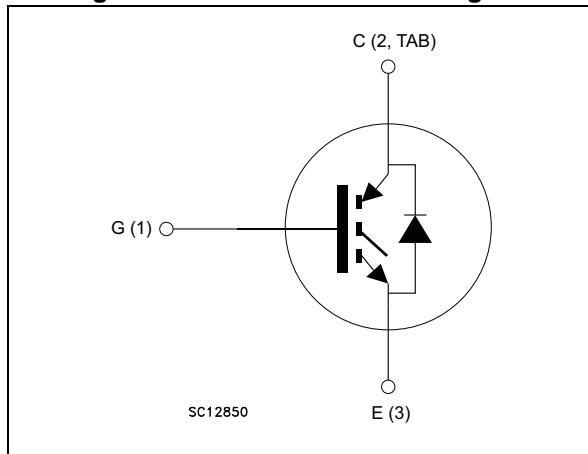


Table 1. Device summary

Order code	Marking	Package	Packaging
STGW20IH125DF	G20IH125DF	TO-247	Tube
STGWT20IH125DF	G20IH125DF	TO-3P	Tube

Features

- Designed for soft commutation only
- Maximum junction temperature: $T_J = 175^\circ\text{C}$
- Minimized tail current
- $V_{CE(\text{sat})} = 2.0 \text{ V (typ.)} @ I_C = 15 \text{ A}$
- Tight parameters distribution
- Safe paralleling
- Very low V_F soft recovery co-packaged diode
- Low thermal resistance
- Lead free package

Applications

- Induction heating
- Microwave oven
- Resonant converters

Description

These IGBTs are developed using an advanced proprietary trench gate field-stop structure and performance is optimized in both conduction and switching losses. A freewheeling diode with a low drop forward voltage is co-packaged. The result is a product specifically designed to maximize efficiency for any resonant and soft-switching application.

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage ($V_{GE} = 0$)	1250	V
I_C	Continuous collector current at $T_C = 25^\circ\text{C}$	40	A
I_C	Continuous collector current at $T_C = 100^\circ\text{C}$	20	A
$I_{CP}^{(1)}$	Pulsed collector current	80	A
V_{GE}	Gate-emitter voltage	± 20	V
I_F	Continuous forward current at $T_C = 25^\circ\text{C}$	40	A
I_F	Continuous forward current at $T_C = 100^\circ\text{C}$	20	A
$I_{FP}^{(1)}$	Pulsed forward current	80	A
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$	259	W
T_{STG}	Storage temperature range	- 55 to 150	$^\circ\text{C}$
T_J	Operating junction temperature	- 55 to 175	$^\circ\text{C}$

1. Pulse width limited by maximum junction temperature

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance junction-case IGBT	0.58	$^\circ\text{C}/\text{W}$
R_{thJC}	Thermal resistance junction-case diode	1.47	$^\circ\text{C}/\text{W}$
R_{thJA}	Thermal resistance junction-ambient	50	$^\circ\text{C}/\text{W}$

2 Electrical characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified.

Table 4. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage ($V_{GE} = 0$)	$I_C = 2 \text{ mA}$	1250			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 15 \text{ A}$		2	2.5	V
		$V_{GE} = 15 \text{ V}, I_C = 15 \text{ A}$ $T_J = 125^\circ\text{C}$		2.2		
		$V_{GE} = 15 \text{ V}, I_C = 15 \text{ A}$ $T_J = 175^\circ\text{C}$		2.3		
		$V_{GE} = 15 \text{ V}, I_C = 30 \text{ A}$		2.55		
V_F	Forward on-voltage	$I_F = 15 \text{ A}$		1.1	1.5	V
		$I_F = 15 \text{ A}$ $T_J = 125^\circ\text{C}$		1.05		
		$I_F = 15 \text{ A}$ $T_J = 175^\circ\text{C}$		1		
		$I_F = 30 \text{ A}$		1.25		
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 500 \mu\text{A}$	5	6	7	V
I_{CES}	Collector cut-off current ($V_{GE} = 0$)	$V_{CE} = 1250 \text{ V}$			25	μA
I_{GES}	Gate-emitter leakage current ($V_{CE} = 0$)	$V_{GE} = \pm 20 \text{ V}$			250	nA

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz},$ $V_{GE} = 0$	-	1290	-	pF
C_{oes}	Output capacitance		-	96	-	pF
C_{res}	Reverse transfer capacitance		-	30.6	-	pF
Q_g	Total gate charge	$V_{CC} = 600 \text{ V}, I_C = 15 \text{ A},$ $V_{GE} = 15 \text{ V}$, see Figure 25	-	69	-	nC
Q_{ge}	Gate-emitter charge		-	7.2	-	nC
Q_{gc}	Gate-collector charge		-	40.8	-	nC

Table 6. IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(off)}$	Turn-off delay time	$V_{CE} = 600 \text{ V}$, $I_C = 15 \text{ A}$, $R_G = 10 \Omega$, $V_{GE} = 15 \text{ V}$, see Figure 23		106		ns
t_f	Current fall time		-	79	-	ns
$E_{off}^{(1)}$	Turn-off switching losses		-	410	-	μJ
$t_{d(off)}$	Turn-off delay time	$V_{CE} = 600 \text{ V}$, $I_C = 15 \text{ A}$, $R_G = 10 \Omega$, $V_{GE} = 15 \text{ V}$, $T_J = 175 \text{ }^\circ\text{C}$, see Figure 23		109		ns
t_f	Current fall time		-	176	-	ns
$E_{off}^{(1)}$	Turn-off switching losses		-	820	-	μJ

1. Turn-off losses include also the tail of the collector current.

Table 7. IGBT switching characteristics (capacitive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{off}^{(1)}$	Turn-off switching losses	$V_{CC} = 900 \text{ V}$, $R_G = 10 \Omega$, $I_C = 30 \text{ A}$, $L = 500 \mu\text{H}$, $C_{snub} = 330 \text{ nF}$, see Figure 24	-	163	-	μJ
		$V_{CC} = 900 \text{ V}$, $R_G = 10 \Omega$, $I_C = 30 \text{ A}$, $L = 500 \mu\text{H}$, $C_{snub} = 330 \text{ nF}$, $T_J = 175 \text{ }^\circ\text{C}$, see Figure 24	-	366	-	

1. Turn-off losses include also the tail of the collector current.

2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

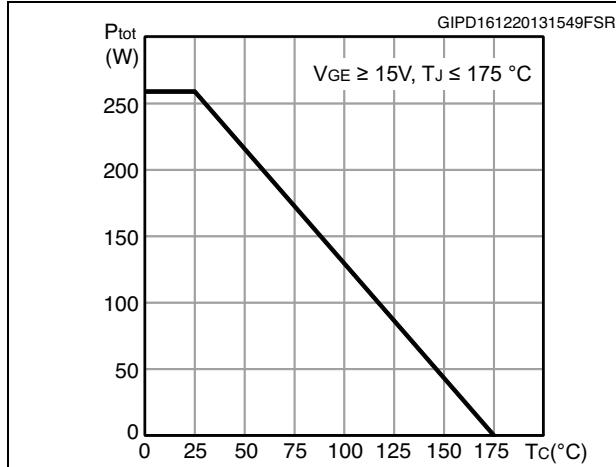


Figure 3. Collector current vs. case temperature

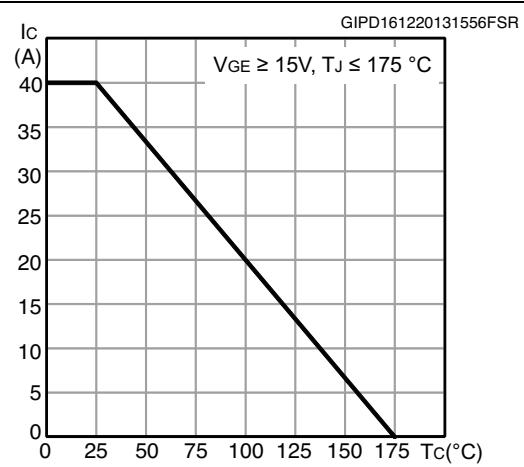


Figure 4. Output characteristics ($T_J = 25^\circ C$)

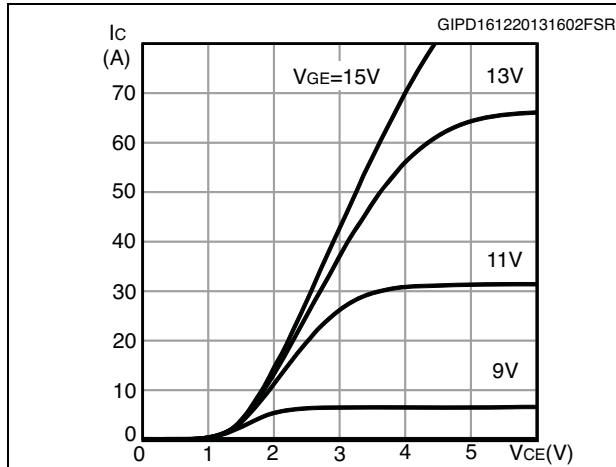


Figure 5. Output characteristics ($T_J = 175^\circ C$)

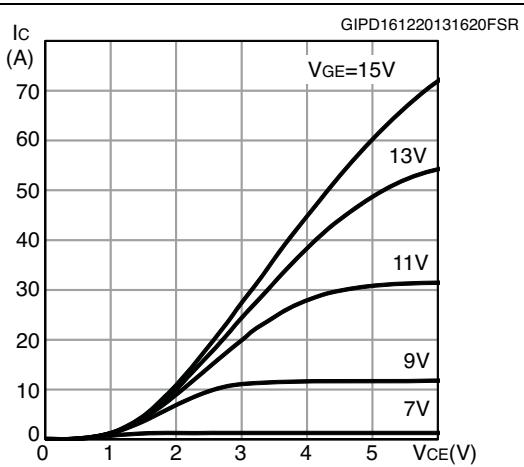


Figure 6. $V_{CE(sat)}$ vs. junction temperature

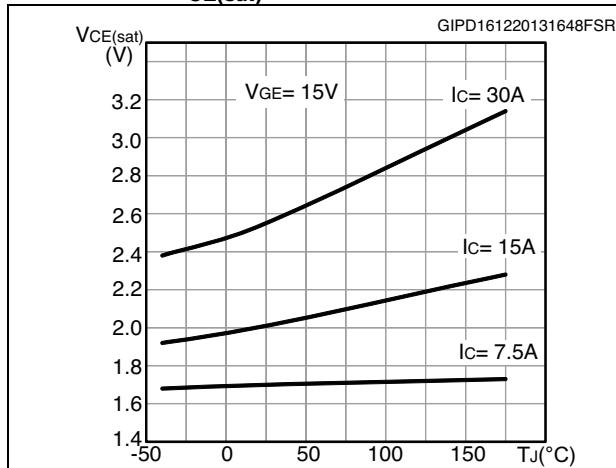


Figure 7. $V_{CE(sat)}$ vs. collector current

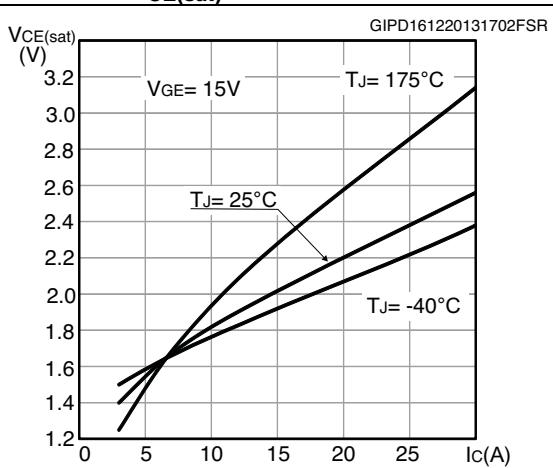


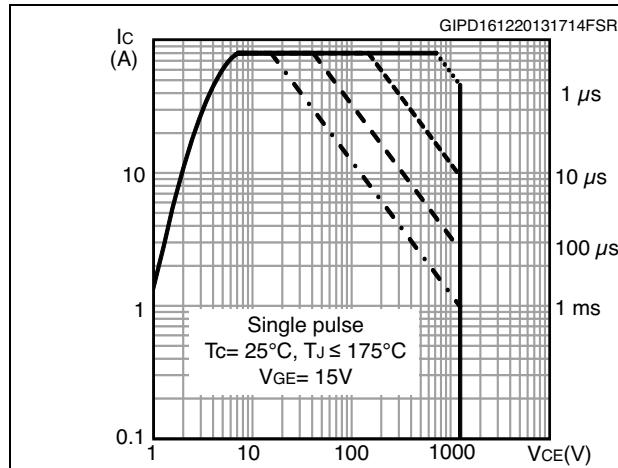
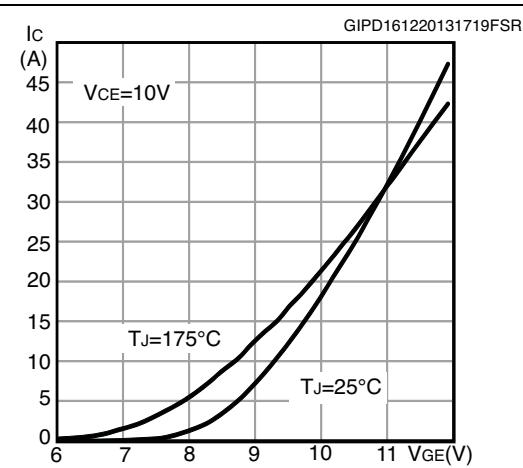
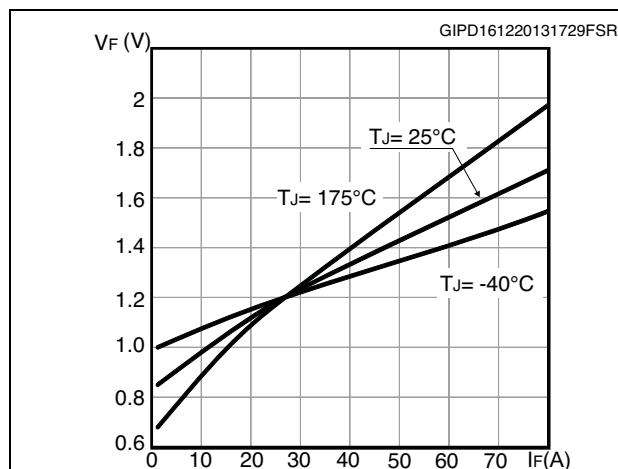
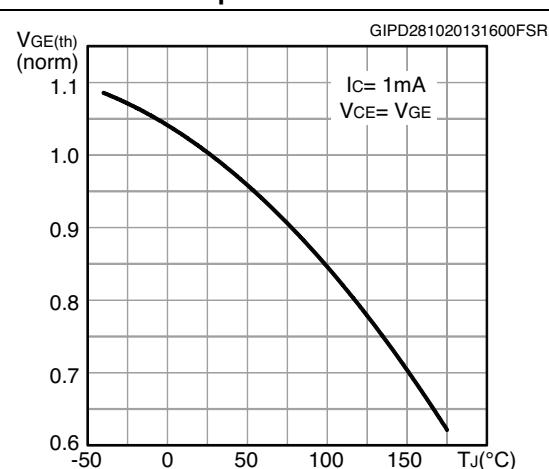
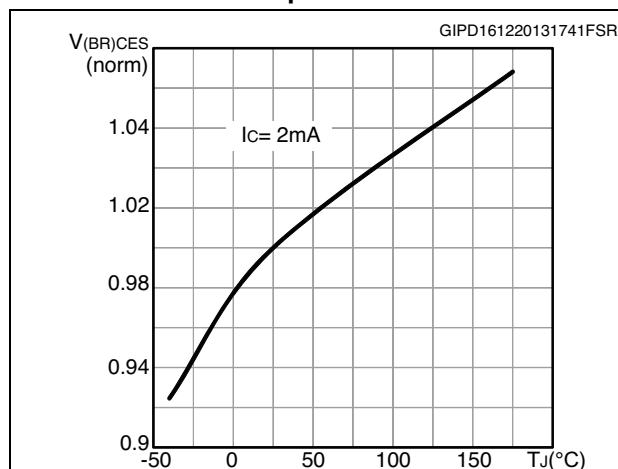
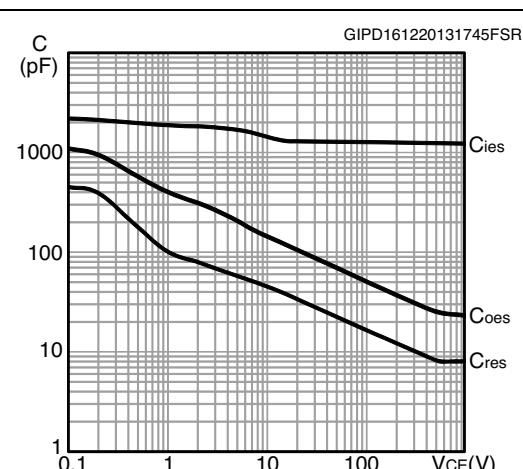
Figure 8. Forward bias safe operating area**Figure 9. Transfer characteristics****Figure 10. Diode V_F vs. forward current****Figure 11. Normalized V_{GE(th)} vs junction temperature****Figure 12. Normalized V_{(BR)CES} vs. junction temperature****Figure 13. Capacitance variation**

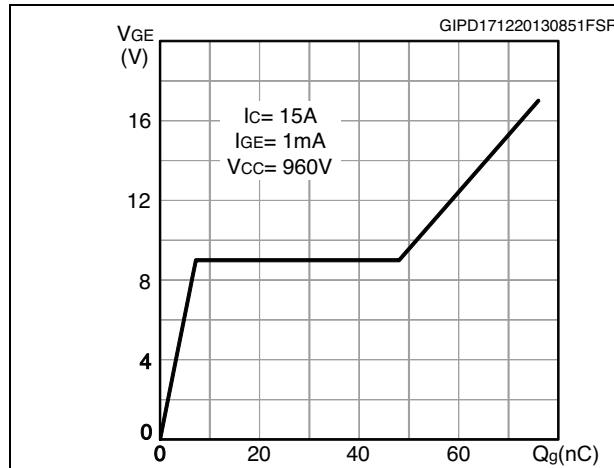
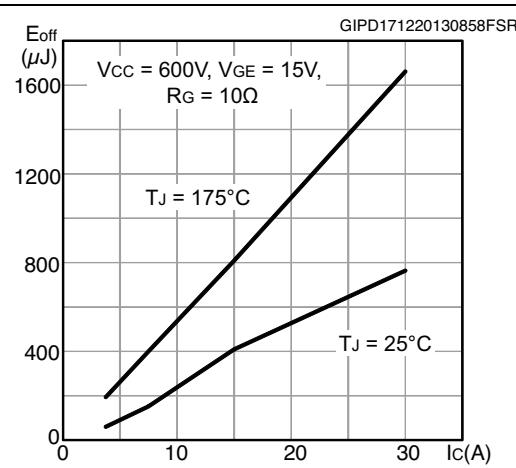
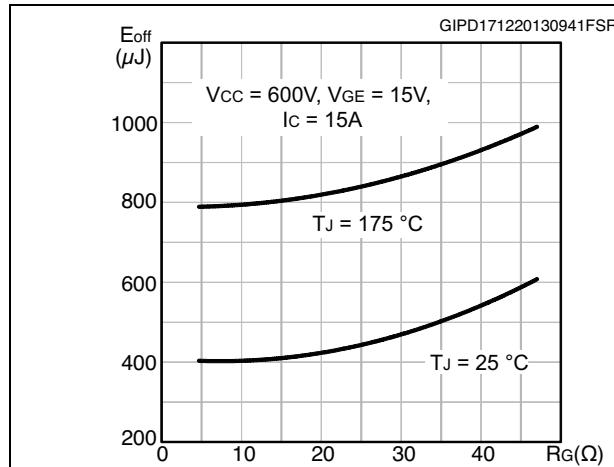
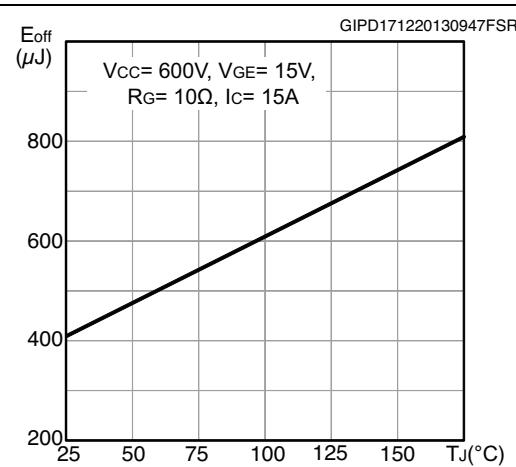
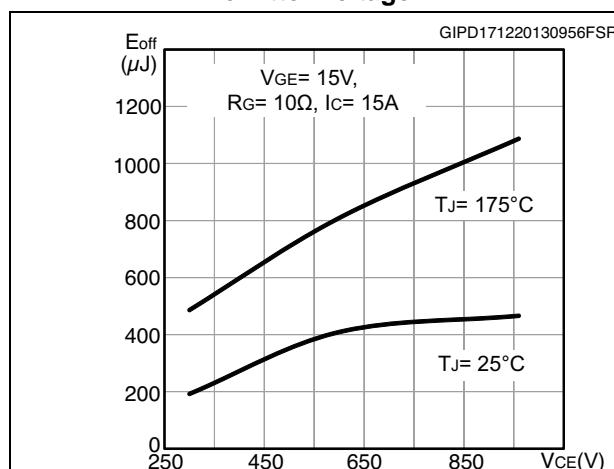
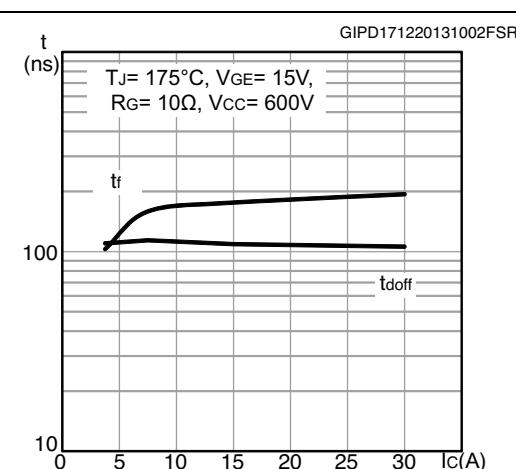
Figure 14. Gate charge vs. gate-emitter voltage**Figure 15. Switching loss vs collector current****Figure 16. Switching-off loss vs gate resistance****Figure 17. Switching-off loss vs temperature****Figure 18. Switching-off loss vs collector-emitter voltage****Figure 19. Switching times vs. collector current**

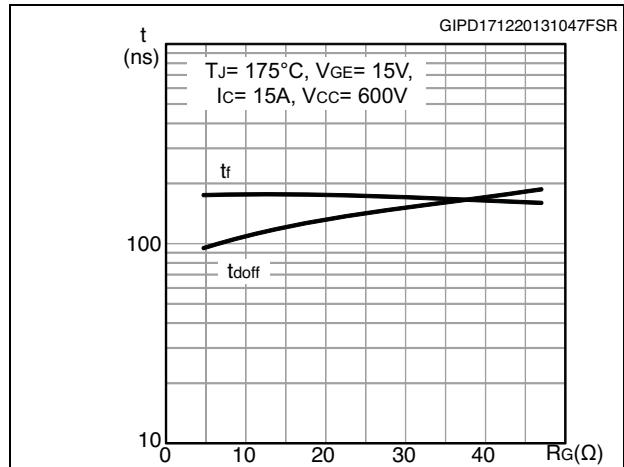
Figure 20. Switching times vs. gate resistance

Figure 21. Thermal impedance for IGBT

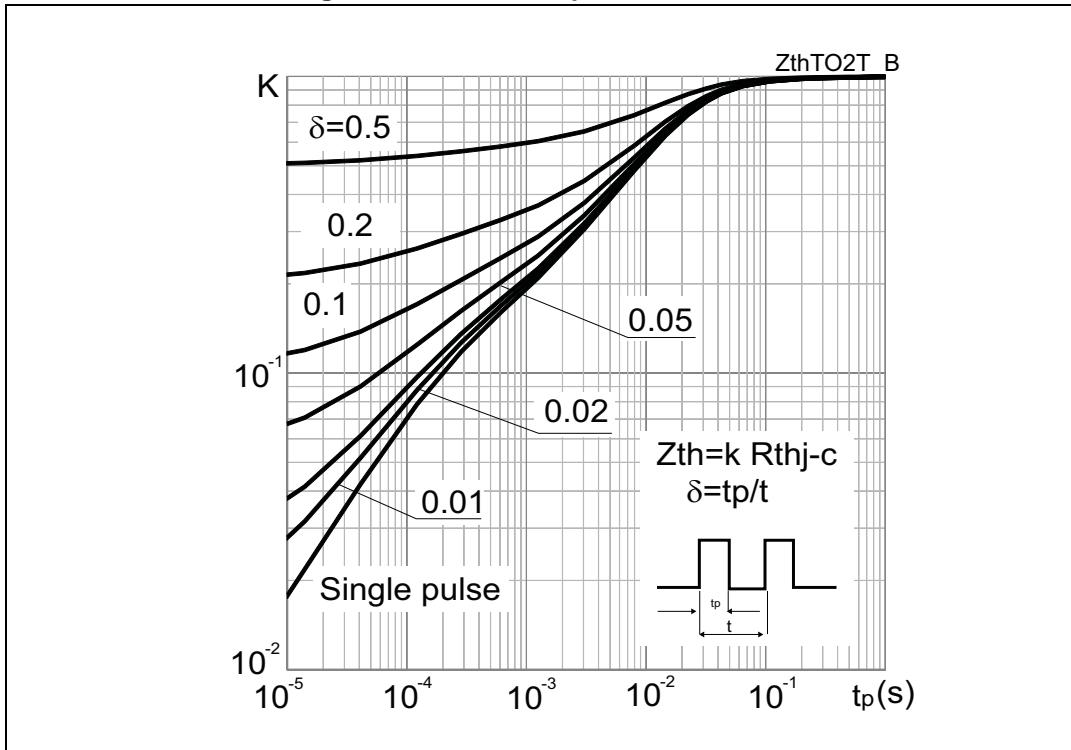
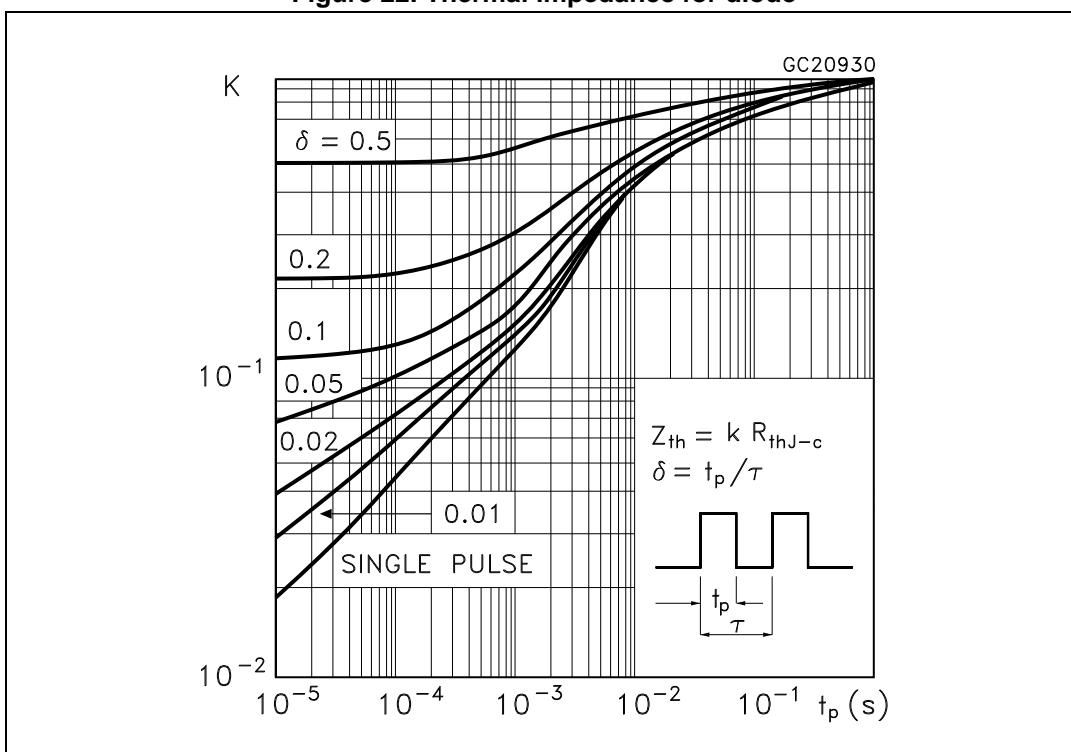


Figure 22. Thermal impedance for diode



3 Test circuits

Figure 23. Test circuit for inductive load switching

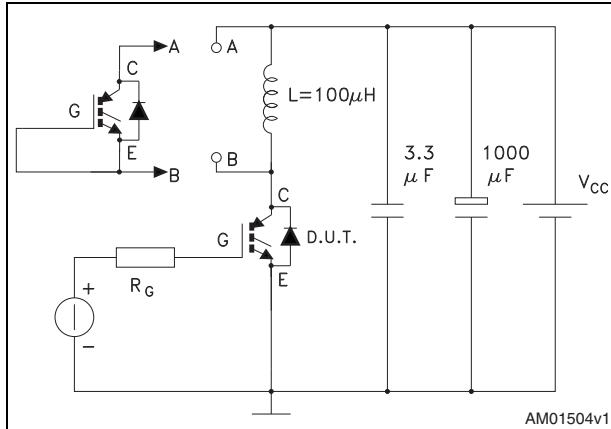


Figure 24. Test circuit for capacitive load switching

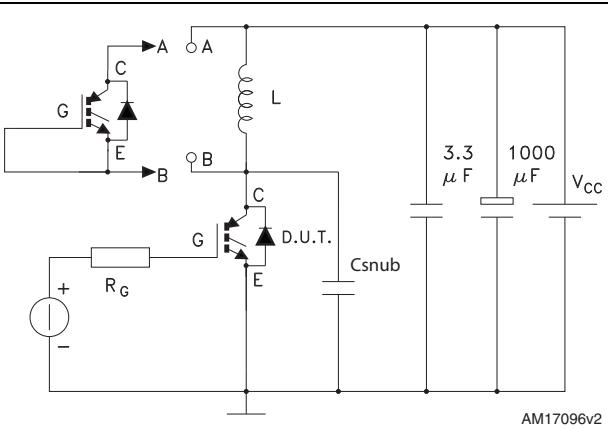


Figure 25. Gate charge test circuit

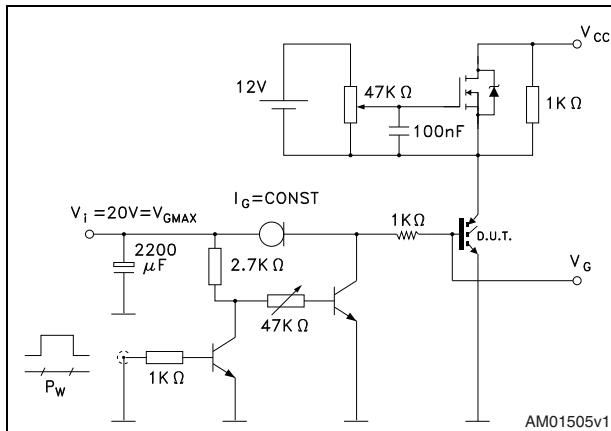
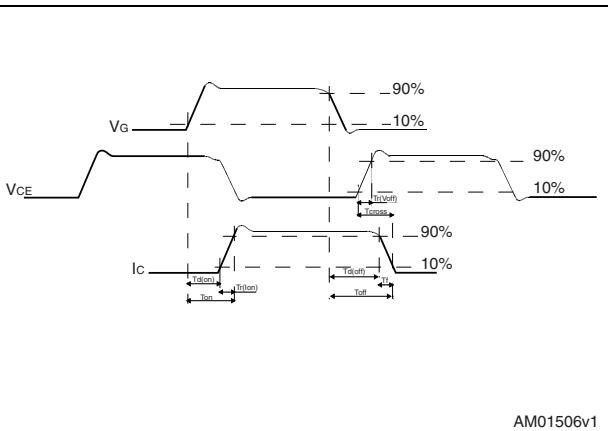


Figure 26. Switching waveform



4 Package mechanical data

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Figure 27. TO-247 drawing

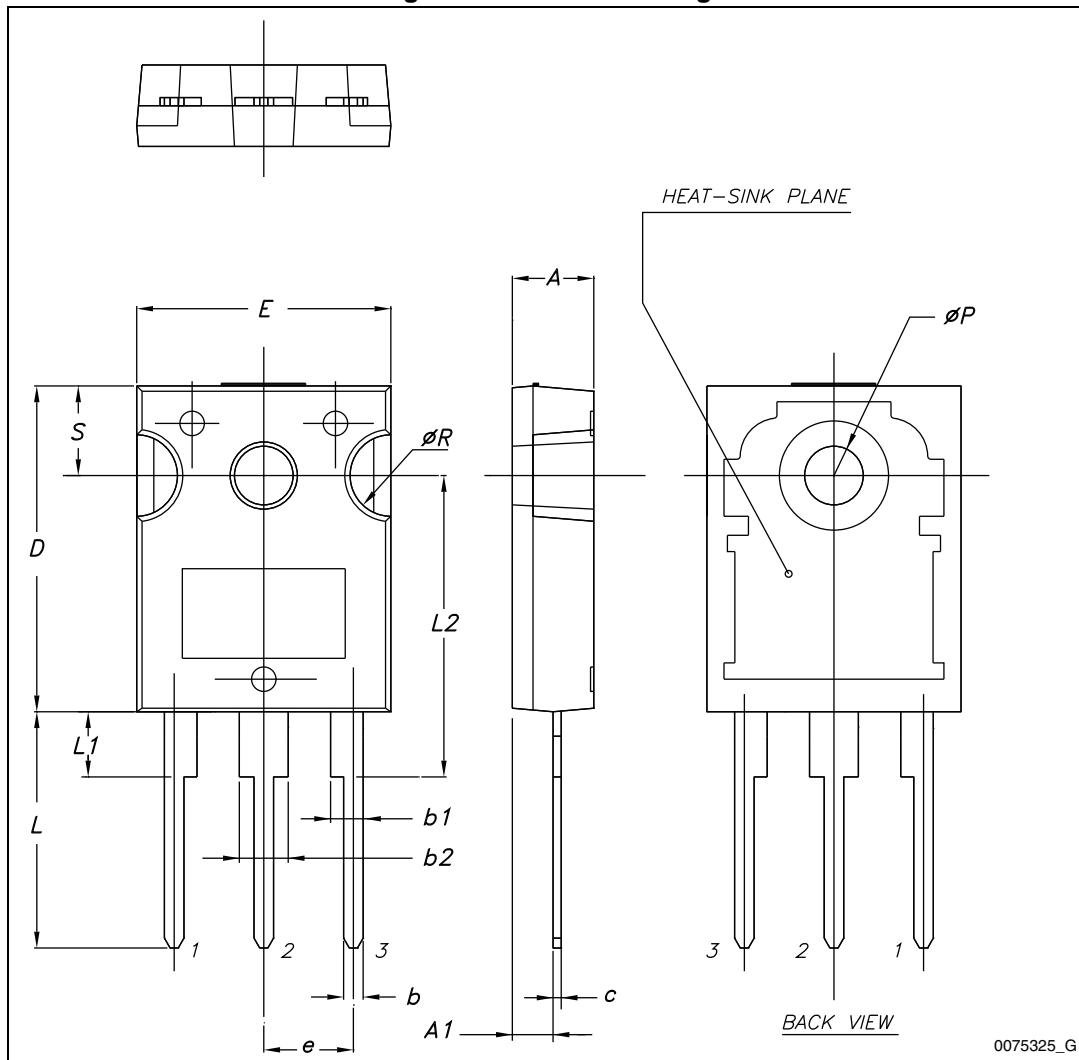


Table 8. TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 28. TO-3P drawing

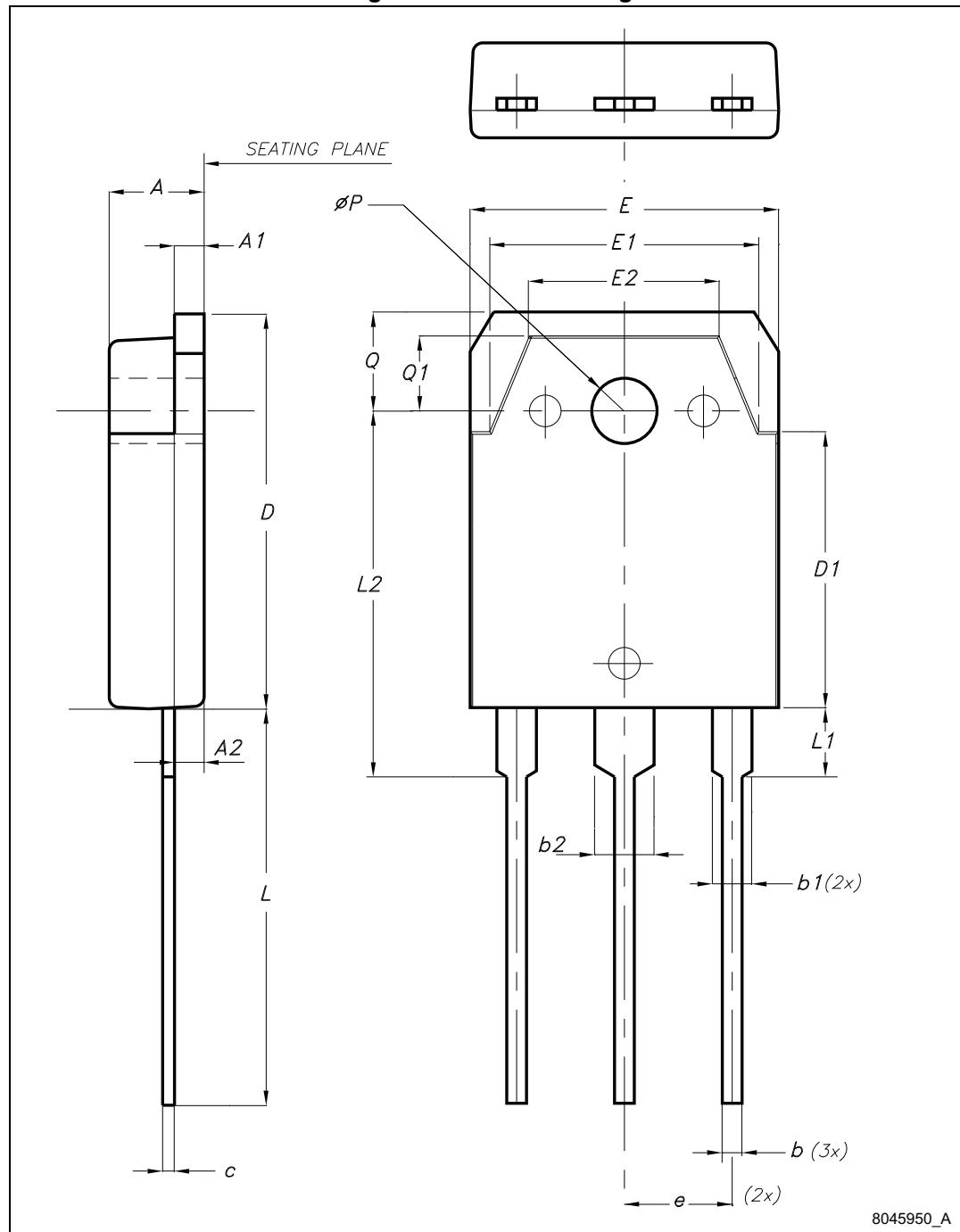


Table 9. TO-3P mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.60		5
A1	1.45	1.50	1.65
A2	1.20	1.40	1.60
b	0.80	1	1.20
b1	1.80		2.20
b2	2.80		3.20
c	0.55	0.60	0.75
D	19.70	19.90	20.10
D1		13.90	
E	15.40		15.80
E1		13.60	
E2		9.60	
e	5.15	5.45	5.75
L	19.50	20	20.50
L1		3.50	
L2	18.20	18.40	18.60
øP	3.10		3.30
Q		5	
Q1		3.80	

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
13-Jan-2014	1	Initial release.
03-Feb-2014	2	Added $V_{CE(sat)}$ max value in Table 5: Dynamic characteristics . Minor text changes.

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"LifeElectronics" LLC

ИНН 7805602321 КПП 780501001 Р/С 40702810122510004610 ФАКБ "АБСОЛЮТ БАНК" (ЗАО) в г.Санкт-Петербурге К/С 30101810900000000703 БИК 044030703

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- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
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- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

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- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



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